



# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

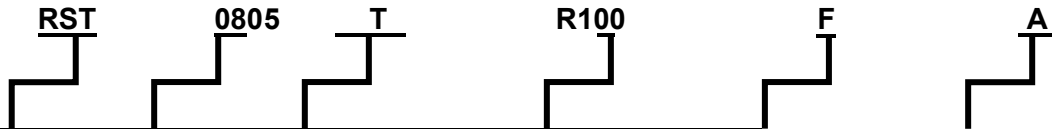
Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	1

## 1 Scope:

- 1.1 This specification is applicable to lead free and halogen free of ROHS directive for RST series low-resistance thick film chip resistors.
- 1.2 Superior Sulfur resistant capability (Refer to ASTM-B-809-95&EIA977sulfur vapor test).
- 1.3 The product is for general electronic purpose.

## 2 Explanation Of Part Number:

(EX)



Type	Size	Packaging	Nominal Resistance		Resistance Tolerance	FoS Test
Anti-Sulfurated Low Resistance Thick Film Chip Resistors	0402 0603 0805 1206 1210 2010 2512	T: Taping type	4-Digit	EX.0.1Ω=R100	F=± 1% J=± 5%	A : 60°C

IE		QA		備註	發行管制章DATA Center.
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# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.

IE-SP-179

Released Date

2021/08/31

Page No.

2

## 3 General Specifications:

Type	Rated Power at 70°C	Max. Working Voltage	Max. Overload Voltage	T.C.R (ppm/°C)	Resistance Range
					F(±1%) · J(±5%) E-24 · E-96
RST (0402)	$\frac{1}{16}$ W	1.44A	3.60A	±1500	$30\text{m}\Omega \leq R < 37\text{m}\Omega$
				±1200	$37\text{m}\Omega \leq R < 60\text{m}\Omega$
				±600	$60\text{m}\Omega \leq R < 100\text{m}\Omega$
				±500	$100\text{m}\Omega \leq R < 400\text{m}\Omega$
				±300	$400\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (0603)	$\frac{1}{10}$ W	1.82A	4.56A	±1500	$30\text{m}\Omega \leq R < 37\text{m}\Omega$
				±1200	$37\text{m}\Omega \leq R < 60\text{m}\Omega$
				±600	$60\text{m}\Omega \leq R < 100\text{m}\Omega$
				±200	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (0805)	$\frac{1}{8}$ W	2.50A	6.25A	±1200	$20\text{m}\Omega \leq R < 33\text{m}\Omega$
				±800	$33\text{m}\Omega \leq R < 50\text{m}\Omega$
				±600	$50\text{m}\Omega \leq R < 100\text{m}\Omega$
				±300	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (1206)	$\frac{1}{3}$ W	4.08A	10.20A	±1200	$20\text{m}\Omega \leq R < 25\text{m}\Omega$
				±1000	$25\text{m}\Omega \leq R < 50\text{m}\Omega$
				±600	$50\text{m}\Omega \leq R < 100\text{m}\Omega$
				±300	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (1210)	$\frac{1}{2}$ W	5.00A	12.50A	±1000	$20\text{m}\Omega \leq R < 25\text{m}\Omega$
				±700	$25\text{m}\Omega \leq R < 50\text{m}\Omega$
				±400	$50\text{m}\Omega \leq R < 100\text{m}\Omega$
				±300	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (2010)	$\frac{3}{4}$ W	6.12A	15.31A	±1200	$20\text{m}\Omega \leq R < 25\text{m}\Omega$
				±900	$25\text{m}\Omega \leq R < 50\text{m}\Omega$
				±500	$50\text{m}\Omega \leq R < 100\text{m}\Omega$
				±300	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
RST (2512)	1W	7.07A	17.67A	±1200	$20\text{m}\Omega \leq R < 25\text{m}\Omega$
				±900	$25\text{m}\Omega \leq R < 50\text{m}\Omega$
				±500	$50\text{m}\Omega \leq R < 100\text{m}\Omega$
				±300	$100\text{m}\Omega \leq R < 1000\text{m}\Omega$
Operating Temperature Range				-55°C ~ +155°C	

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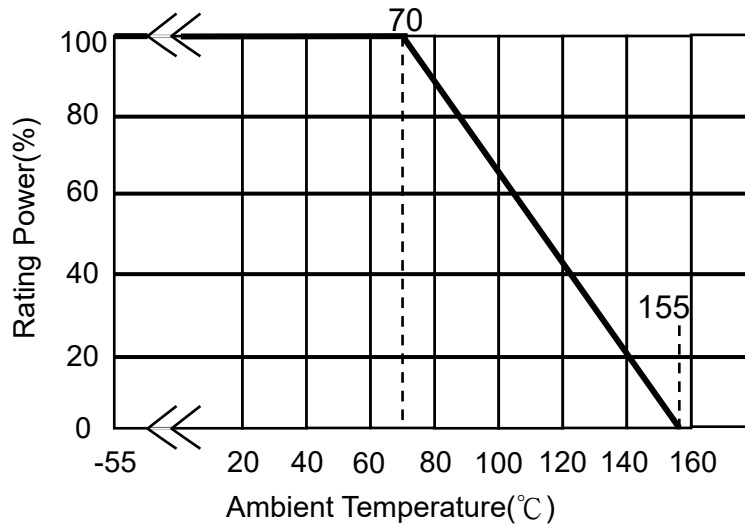
# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	3

### 3.1 Power Derating Curve:

Temperature Range: -55°C ~ +155°C

If the ambient temperature exceeds 70 degrees centigrade to 155 degrees centigrade, the power can be modified by the curve as below.



### 3.2 Current Rating:

Rated Current: DC current or AC current (rms) based on the rated power.

The current can be calculated by the following formula. If the calculated value exceeds the Max. current specified in the Table 3, the Max. current rating is set as the current rating.

$$I = \sqrt{P/R}$$

I= Rated current (A)  
P= Power rating (W)  
R= Nominal resistance(Ω)

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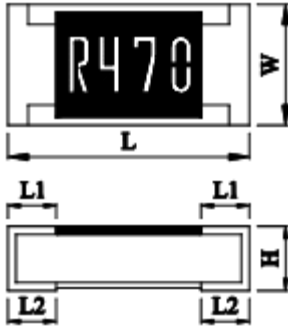


# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	4

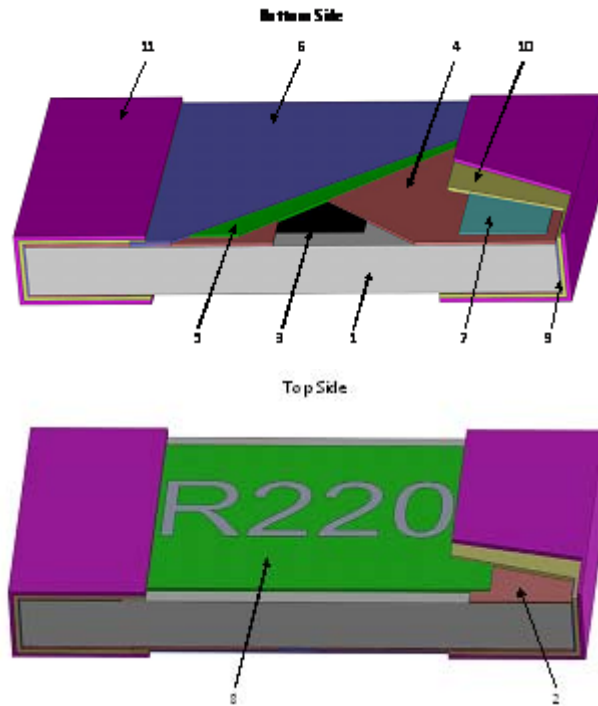
## 4 Dimensions:

Unit:mm



Dimension		L	W	H	L1	L2
Type	Size Code					
RST	0402	1.00±0.10	0.50±0.05	0.30±0.10	0.25±0.10	0.20±0.15
RST	0603	1.60±0.10	0.80±0.10	0.45±0.10	0.25±0.15	0.35±0.15
RST	0805	2.00±0.10	1.25±0.10	0.50±0.10	0.35±0.20	0.35±0.20
RST	1206	3.05±0.10	1.55±0.10	0.50±0.10	0.45±0.20	0.55±0.25
RST	1210	3.05±0.10	2.55±0.10	0.55±0.10	0.50±0.20	0.50±0.20
RST	2010	5.00±0.20	2.50±0.20	0.60±0.10	0.65±0.20	0.65±0.20
RST	2512	6.30±0.20	3.20±0.20	0.60±0.10	0.65±0.20	0.65±0.20

## 5 Structure Graph:



1	Ceramic substrate	7	2nd Bottom inner electrode
2	Top inner electrode	8	G2 layer+Marking
3	Resistive layer	9	Terminal inner electrode
4	1 <sup>st</sup> Bottom inner electrode	10	Ni plating
5	1st Protective coating	11	Sn plating
6	2nd Protective coating		

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# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.

IE-SP-179

Released Date

2021/08/31

Page No.

5

## 6 Reliability Test:

Item	Conditions	Specifications
		Resistors
High Temperature Exposure (Storage)	Put the specimens in the chamber with temperature of 155±3°C for 1000 hours. Then take them out to stabilize in room temperature for 24±4hr or more, and measure of its resistance variance rate.  Experiment evidence: AEC-Q200	ΔR%=±2.0%
Temperature Cycling	Put the specimens in the High & low temperature test chamber with temperature varies from -55°C to 125°C for 15 minutes and total 1000 cycles. Then take them out to stabilize in room temperature for 24±4hr or more, and measure of its resistance variance rate.  Experiment evidence: AEC-Q200	ΔR%=±2.0%
Short Time Overload	Applied 2.5 times rated current for 5 seconds and release the load for about 30 minutes, then measure its resistance variance rate. (Rated current refers to item 3. general specifications)  Refer to JIS-C5201-1 4.13	ΔR%=±2.0%
Biased Humidity	Solder the specimens on the test PCB and put them into the constant temperature humidity chamber with 85±2°C and 85±5%RH. Then apply the test current that calculates based on the 10% of rated power for 1000hrs. Then take them out to stabilize in room temperature for 24±4hr or more, and measure of its resistance variance rate.  Experiment evidence: AEC-Q200	ΔR%=±3.0%
Operational Life	Solder the specimens on the test PCB and Put them in the chamber with temperature of 125±3°C and load the current for 1000 hours. Then take them out to stabilize in room temperature for 24±4hr or more, and measure of its resistance variance rate. Note: The input current shall refer to the power de-rating curve (referring to page 2, No.3.1)  Experiment evidence: AEC-Q200	ΔR%=±3.0%
Board Flex (Bending Test)	Solder the specimens on the test PCB and put the PCBA onto the Bending Tester. Add force at the central part of PCB, and the duration of the applied forces shall be 60 (+ 5) Sec. Measure of its resistance variance rate in load. Bending depth D: 0402 · 0603 · 0805=5mm 1206 · 1210=3mm 2010 · 2512=2mm  Experiment evidence: AEC-Q200	ΔR%=±2.0% No mechanical damage, peel-off of side end or chip crack.

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Series No. **60**



# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	6

Item	Conditions	Specifications	
		Resistors	
Resistance to Soldering Heat	The specimens are fully immersed into the Pb-free solder pot, then take them out to stabilize for 1 hour or more and measure of its resistance variance rate. Temp of solder pot : 260±5°C Soldering duration : 10±1sec.  Experiment evidence AEC-Q200	ΔR%=±2.0%	
ESD	Put the specimens on the test fixture and two (2)discharges (2KVDC) shall be applied to each PUT, one (1) with a positive polarity and one (1) with a negative polarity. Afterwards, the specimens stabilize for 30min or more and measure of its resistance variance rate. The test is performed with direct contact and regular discharge mode. The resistor and capacitor used on the spearhead is 2000Ω and 150pF respectively.  Experiment evidence AEC-Q200	ΔR%=±3.0%	
Solderability	<b>Test method:</b> <b>Test item 1 (solder pot test): Method B</b> Precondition: The specimens are subjected to 155°C dry bake for 4hrs±15min. The specimens are immersed into the flux first, then fully immersed into the solder pot, at a temperature of 235± 5°C for 5+0/-0.5 sec. Then rinse with water and observe the soldering coverage under the microscope. <b>Test item 2 (Leaching test): Method D</b> The specimens are immersed into the flux first, then fully immersed into the solder pot, at a temperature of 260±5°C for 30+0/-0.5 sec. Then rinse with water and observe the soldering coverage under the microscope.  Experiment evidence AEC-Q200	1.Soldering coverage over 95% 2.At the edge of terminal, the object underneath (e.g. white ceramic) shall not expose.	
Electrical Characterization	$TCR (ppm/°C) = \frac{(R2-R1)}{R1(T2-T1)} \times 10^6$ R1: Resistance at room temperature (Ω) R2: Resistance at -55°C or +125°C(Ω) T1: Room temperature (°C) T2: Temperature -55°C or +125°C  Experiment evidence: AEC-Q200	Refer to item 3. General specifications	
Sulfuration Test	Class : A Put the tested resistor in sulfur vapor, at a temperature of 60±2°C for 1000hrs Refer to ASTM-B-809-95&EIA977	ΔR=±4.0%	Refer to item 3. general specifications

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# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	7

## 7 Measurement Point:

Measure from bottom electrodes		Unit : mm	
	DIM TYPE	A	B
		RST0402	0.80±0.05
	RST0603	1.35±0.05	0.35±0.05
	RST0805	1.80±0.05	0.35±0.05
	RST1206	2.90±0.05	0.35±0.05
	RST1210	2.90±0.05	0.35±0.05
	RST2010	4.50±0.05	1.15±0.05
	RST2512	5.90±0.05	1.60±0.05

## 8 Plating Thickness:

- 8.1 Ni:  $\geq 2 \mu m$
- 8.2 Sn(Tin):  $\geq 3 \mu m$
- 8.3 Sn(Tin): Matte Sn

## 9 Rule of package empty quantity:

- 9.1 Empty quantity for each reel is not allowed to exceed 0.1% of the whole quantity, and continuous 2pcs (included) empty are also unallowed.

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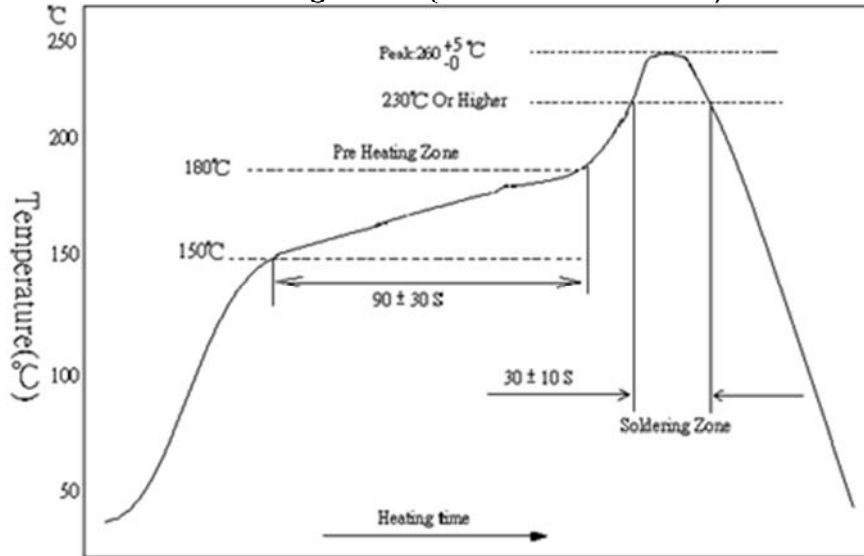
Series No. **60**



**10 Technical application notes: (This is for recommendation, please customer perform adjustment according to actual application)**

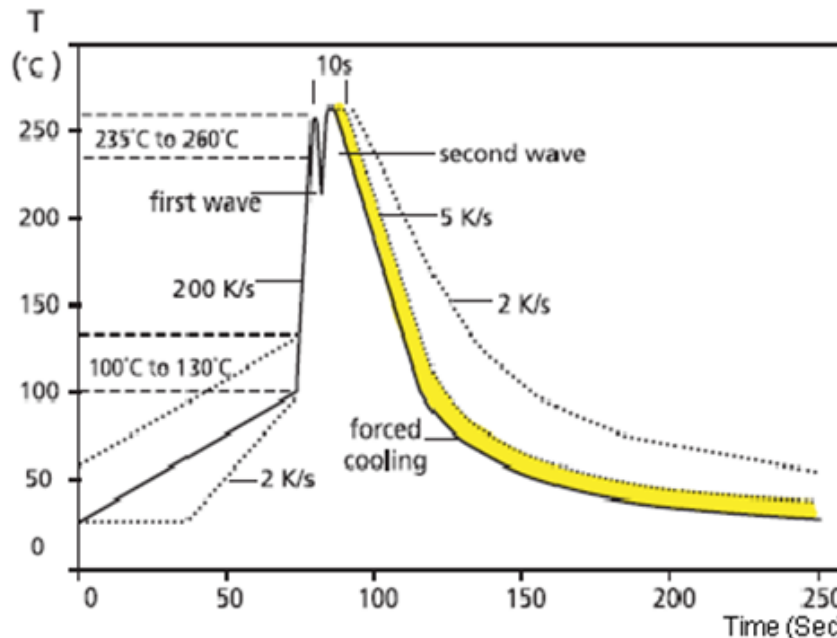
10.1 Recommend Soldering Method:

10.1.1 Lead Free IR Reflow Soldering Profile(MEET J-STD-020D)



Remark: Remark: The peak temperature of soldering heat is 260 +5/-0 °C for 10 seconds.

10.1.2 Lead Free Double-Wave Soldering Profile. (This applies to 0603 and above size products )



10.1.3 Soldering Iron: temperature 350°C ± 10°C, dwell time shall be less than 3 sec.

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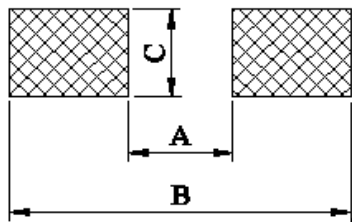
Series No. **60**



**10.2 Recommend Land Pattern Design (For Reflow Soldering)**

When a component is soldered, the resistance after soldering changes slightly depending on the size of the soldering area and the amount of soldering. When designing a circuit, it is necessary to consider the effect of a decrease or increase in its resistance.

Unit:mm



DIM TYPE	A	B	C
<b>RST0402</b>	0.5	1.5	0.6
<b>RST0603</b>	0.8	2.1	0.9
<b>RST0805</b>	1.2	3.0	1.3
<b>RST1206</b>	2.2	4.2	1.6
<b>RST1210</b>	2.2	4.2	2.8
<b>RST2010</b>	3.5	6.1	2.8
<b>RST2512</b>	3.8	8.0	3.5

**10.3 Environment Precautions:**

This specification product is for general electronic use, RALEC will not be responsible for any damage, cost or loss caused by using this specification product in any special environment. If other applications need to confirm with RALEC.

If consumer intends to use our Company product in special environment or condition (including but not limited to those mentioned below), then will need to make individual recognition of product features and reliability accordingly.

- (a) Used in high temperature and humidity environment;
- (b) Exposed to sea breeze or other corrosive gas, such as Cl<sub>2</sub> · H<sub>2</sub>S · NH<sub>3</sub> · SO<sub>2</sub> and NO<sub>2</sub>;
- (c) Used in non-verified liquids including water, oil, chemical and organic solvents;
- (d) Using non-verified resin or other coating material to seal or coat our Company product;
- (e) After soldering, it is necessary to use water-soluble detergents to clean residual solder fluxes, even though no-clean fluxes are recommended.

**10.4 Momentary Overload Precautions:**

The product might be out of function when momentary overloaded. Please make sure to avoid momentary overloading while using and preserving.

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Series No. **60**



# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	10

## 10.5 Operation and Processing Precautions:

- (a) Avoid damage to the edge of resistor and protective layer caused by mechanical stress.
- (b) Handle with care when printing circuit board (PCB) is divided or fixed on support body, because bending of printing circuit board (PCB) mounting will make mechanical stress for resistors.
- (c) Make sure the power rating is under the limit when using the resistor. When power rating is over the limit, the resistor will be overloaded. There might be machinery damage due to the climbing temperature
- (d) If the resistor will be exposed under massive impact load (shock wave) in a short period of time, the working environment must be set up well before use.
- (e) Please make evaluation and confirmation when the product is well used in your company and have a through consideration of its fail-safe design to ensure the system safety.

## 11 Storage and transportation requirement:

- 11.1 The temperature condition must be controlled as  $25\pm 5^{\circ}\text{C}$ , and the R.H. must be controlled as  $60\pm 15\%$ . The stock can maintain quality level in two years.
- 11.2 Please avoid the mentioned harsh environment below when storing to ensure product performance and its' weldability. Places exposed to sea breeze or other corrosive gas, such as  $\text{Cl}_2$ 、 $\text{H}_2\text{S}$ 、 $\text{NH}_3$ 、 $\text{SO}_2$  and  $\text{NO}_2$ .
- 11.3 When the product is moved and stored, please ensure the correct orientation of the box. Do not drop or squeeze the box. Otherwise, the electrode or the body of the product may be damaged.



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# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	11

**12 The carton packaged for electronic-information products is made by the symbol as follows: (For China)**

	
Marking for control of pollution cause by electronic-information products	Marking for package recovery

**13 Attachments:**

13.1 Document Revise Record (QA-QR-027)

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# RST(A) Series Low-Resistance Thick Film Chip Resistors Product Specification

Document No.	IE-SP-179
Released Date	2021/08/31
Page No.	12

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